IAUCN04S6N017T



Automotive MOSFET

OptiMOS™ 6 Power-Transistor







Features

- OptiMOS[™] power MOSFET for automotive applications
- N-channel Enhancement mode Normal Level
- Extended qualification beyond AEC-Q101
- Enhanced electrical testing
- Robust design
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- RoHS compliant
- 100% Avalanche tested
- Top Side Cooling

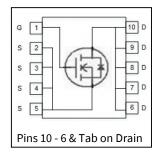
Potential applications

General automotive applications.

Product validation

Qualified for automotive applications. Product validation according to AEC-Q101.





Product Summary

V_{DS}	40	V
R _{DS(on)}	1.73	mΩ
I _D (chip limited)	200	Α

Туре	Package	Marking
IAUCN04S6N017T	PG-LHDSO-10-1	6D4

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Maximum ratings

at Tj=25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I D	V _{GS} =10 V, Chip limitation ^{1,2)}	200	A
		V _{GS} =10V, DC current ¹⁾	120	
		T_a =85 °C, V_{GS} =10 V, R_{thJH} on 2s2p ^{2,4)}	58	
Pulsed drain current ²⁾	I _{D,pulse}	$T_{\rm C}$ =25 °C, $t_{\rm p}$ = 100 μs	520	
Avalanche energy, single pulse ²⁾	E AS	/ _D =40 A	130	mJ
Avalanche current, single pulse	I _{AS}	-	40	А
Gate source voltage	V _{GS}	-	±20	V
Power dissipation	P tot	Т _C =25 °С	103	W
Operating and storage temperature	$T_{\rm j}, T_{\rm stg}$	-	-55 +1 75	°C

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Thermal characteristics²⁾

Parameter	Symbol	Conditions	Values		Unit	
			min.	typ.	max.	
Thermal resistance, junction - case	R thJC	-	-	0.73	1.46	K/W
Thermal characterization parameter, source pin ⁵⁾	ψ_{source}		-	5.4	-	
Thermal characterization parameter, drain pin ⁶⁾	$\psi_{ extit{drain}}$		-	5.3	-	
Thermal resistance, junction - heatsink ⁴⁾	R thJH		_	7.5	_	
Thermal resistance, junction - ambient ³⁾	R thJA	-	-	49	-	

Electrical characteristics

at T_i=25 °C, unless otherwise specified

Parameter	Symbol	Symbol Conditions	Values			Unit
			min.	typ.	max.	
Static characteristics						
Drain-source breakdown voltage	V _{(Br)DSS}	V_{GS} =0 V, I_{D} =1 mA	40	-	-	V
Gate threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 40 \mu A$	2.2	2.6	3.0	
Zero gate voltage drain current	I _{DSS}	V_{DS} =40 V, V_{GS} =0 V, T_{j} =25 °C	-	-	1	μΑ
		V_{DS} =40 V, V_{GS} =0 V, T_{j} =125 °C ²⁾	_	-	14	
Gate-source leakage current	I _{GSS}	V _{GS} =20 V, V _{DS} =0 V	-	-	100	nA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =7 V, I _D =60 A	_	1.78	2.05	mΩ
		V _{GS} =10 V, I _D =60 A	_	1.52	1.73	
Gate resistance ²⁾	R _G	_	-	2.5	_	Ω



Parameter	Symbol	Symbol Conditions		Values		
			min.	typ.	max.	
Dynamic characteristics ²⁾						
Input capacitance	C iss		-	2500	3250	pF
Output capacitance	C oss	V_{GS} =0 V, V_{DS} =25 V, f =1 MHz	_	750	975	
Reverse transfer capacitance	C _{rss}		_	42	63	
Turn-on delay time	t d(on)		-	7	-	ns
Rise time	t _r	V _{DD} =20 V, V _{GS} =10 V,	_	4	-	
Turn-off delay time	t d(off)	I_D =120 A, R_G =3.5 Ω	_	15	-	
Fall time	t _f		_	7	_	
Gate Charge Characteristics ²⁾						
		T			Γ	1
Gate to source charge	Q _{gs}		-	11	14	nC
	Q gs Q gd	V _{DD} =32 V, I _D =120 A,	-	11 8	14	nC
Gate to source charge		V _{DD} =32 V, I _D =120 A, V _{GS} =0 to 10 V				nC
Gate to source charge Gate to drain charge	Q _{gd}	.	_	8	12	nC V
Gate to source charge Gate to drain charge Gate charge total	Q gd Q g	.	-	8	12 49	
Gate to source charge Gate to drain charge Gate charge total Gate plateau voltage	Q gd Q g	.	-	8	12 49	
Gate to source charge Gate to drain charge Gate charge total Gate plateau voltage Reverse Diode	Q gd Q g	V _{GS} =0 to 10 V		8 38 4.3	12 49 -	V
Gate to source charge Gate to drain charge Gate charge total Gate plateau voltage Reverse Diode Diode continous forward current ²⁾	Q gd Q g V plateau	V _{GS} =0 to 10 V T _C =25 °C	-	8 38 4.3	12 49 -	V

¹⁾ Practically the current is limited by the overall system design including the customer-specific PCB.

Reverse recovery charge²⁾

 Q_{rr}

 $di_{F}/dt = 100 A/\mu s$

nC

²⁾ The parameter is not subject to production testing – specified by design.

³⁾ Device on 2s2p FR4 PCB defined in accordance with JEDEC standards (JESD51-5, -7). PCB is vertical in still air.

⁴⁾ Device on 2s2p FR4 PCB defined in accordance with JEDEC standards (JESD51-5, -7) without thermal vias, heatsink of 71x110x2 mm is attached through 3 W/(m*K) 400μm to top side pad. Heatsink fixed to 85°C ambient temperature.

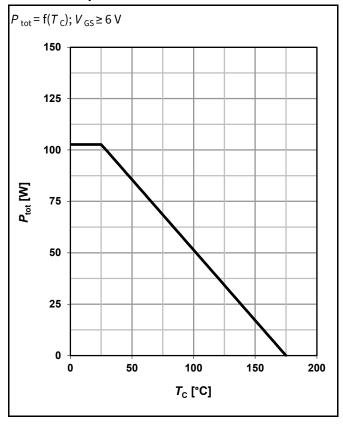
⁵⁾ Thermal characterization parameter, calculated as $\psi_{\text{source}} = (T_{\text{source}} - T_{\text{ambient}})/P_{\text{dis}}$ in condition of 4). Used to determine PCB temperature at source pins for given power.

⁶⁾ Thermal characterization parameter, calculated as ψ_{drain} = (Tdrain - T_{ambient})/P_{dis} in condition of 4). Used to determine PCB temperature at drain pins for given power.

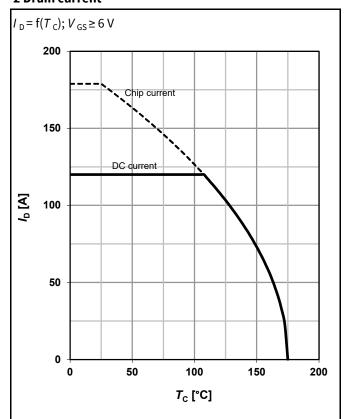


Electrical characteristics diagrams

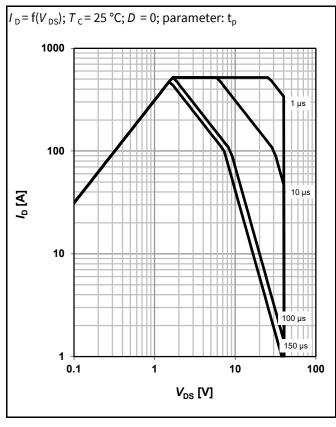
1 Power dissipation



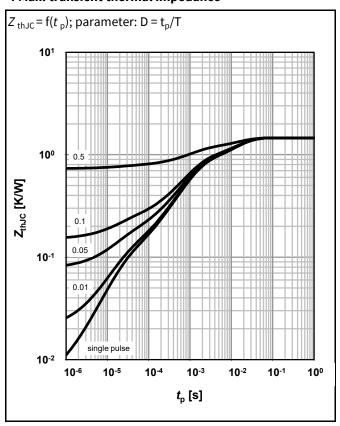
2 Drain current



3 Safe operating area

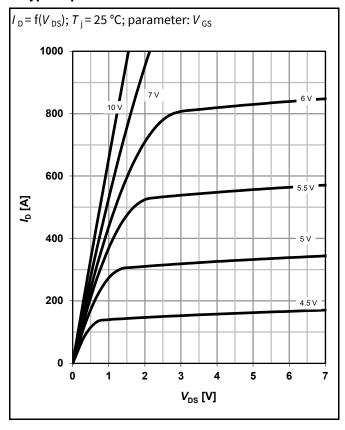


4 Max. transient thermal impedance

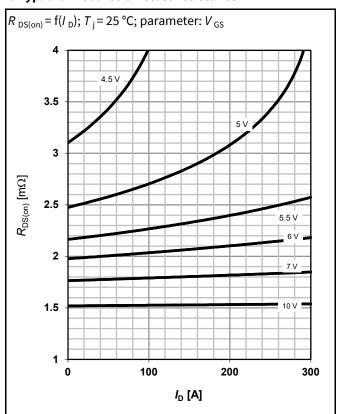




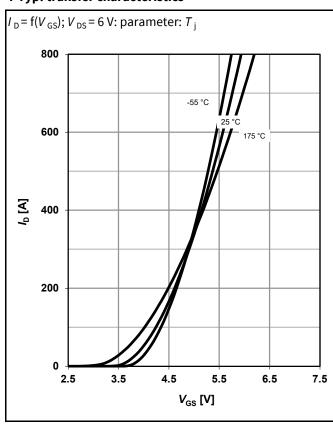
5 Typ. output characteristics



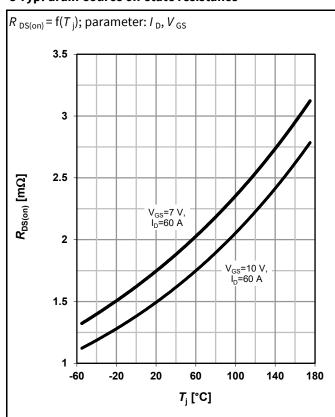
6 Typ. drain-source on-state resistance



7 Typ. transfer characteristics

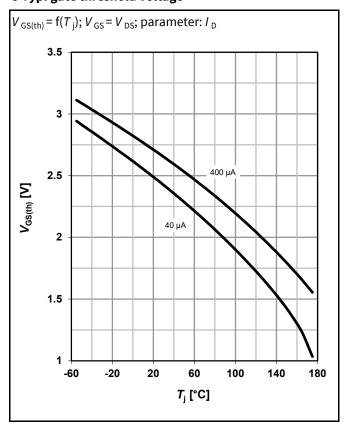


8 Typ. drain-source on-state resistance

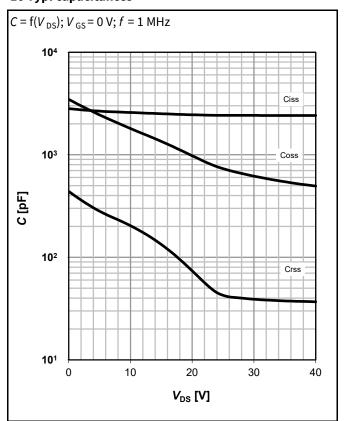


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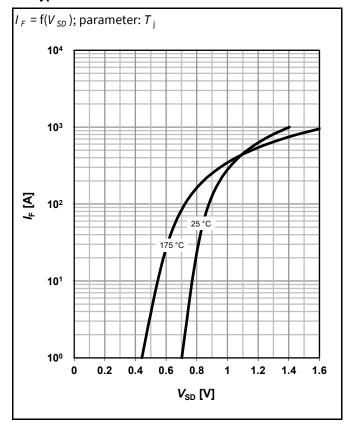
9 Typ. gate threshold voltage



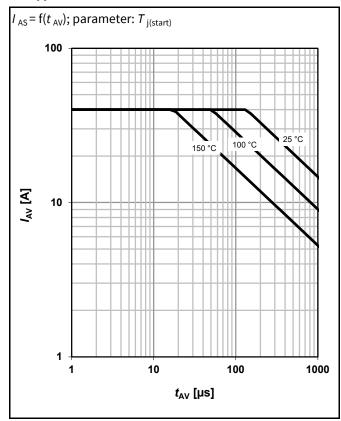
10 Typ. capacitances



11 Typical forward diode characteristics

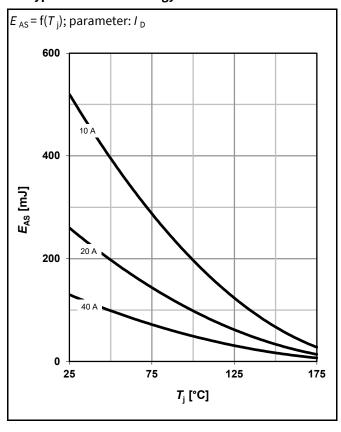


12 Typ. avalanche characteristics

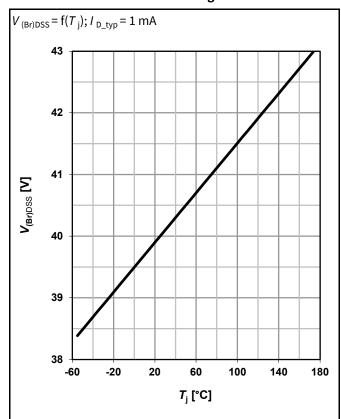


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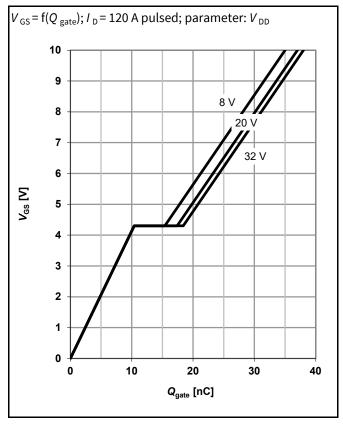
13 Typical avalanche energy



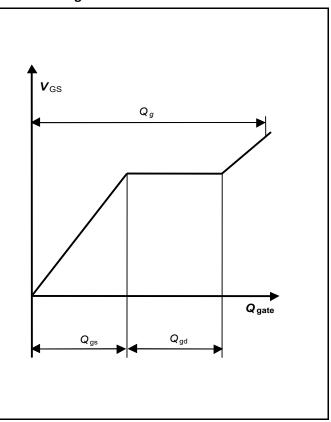
14 Drain-source breakdown voltage



15 Typ. gate charge



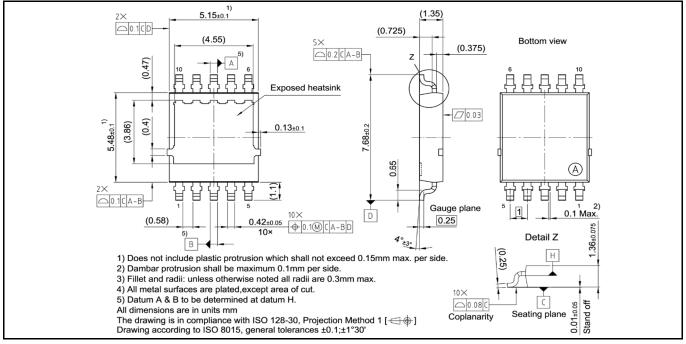
16 Gate charge waveforms



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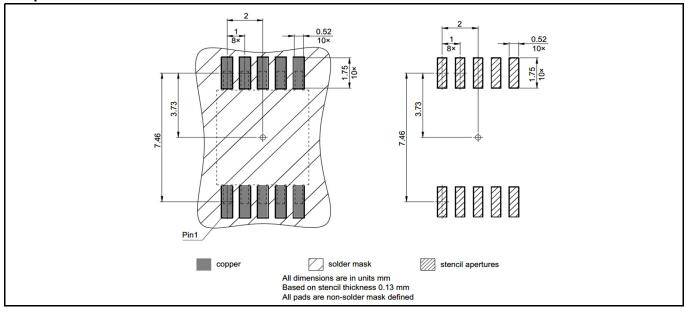


Package Outline

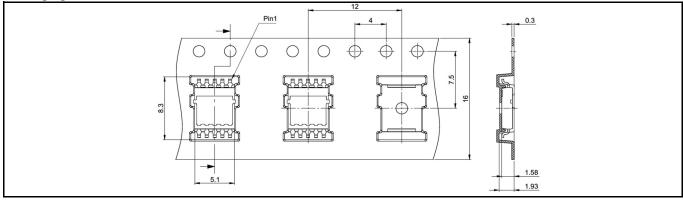


https://www.infineon.com/cms/en/product/packages/PG-LHDSO/PG-LHDSO-10-1

Footprint



Packaging



all dimensions in mm

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Revision History

Revision	Date	Changes
Revision 1.1	21.08.2023	Final Data Sheet
		updated package drawing with harmonized & standardized tolerance
Revision 1.2	31.07.2024	writing methodology

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